


<b>Search Notes</b>  	<b>Application/Control No.</b>  10065546	<b>Applicant(s)/Patent Under Reexamination</b>  NEIMAN ET AL.
	<b>Examiner</b>  Wai, Eric C	<b>Art Unit</b>  2195

SEARCHED			
Class	Subclass	Date	Examiner
718	100, 104-105	08/20/2007	ECW
709	104	12/13/2006	ECW

SEARCH NOTES		
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Inventor's Name Search	12/13/2006	ECW
East Search	12/13/2006	ECW
Updated East Search	08/20/2007	ECW
Google Scholar Search	1/23/2008	ECW
Updated East Search	11/13/2008	ECW

INTERFERENCE SEARCH			
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